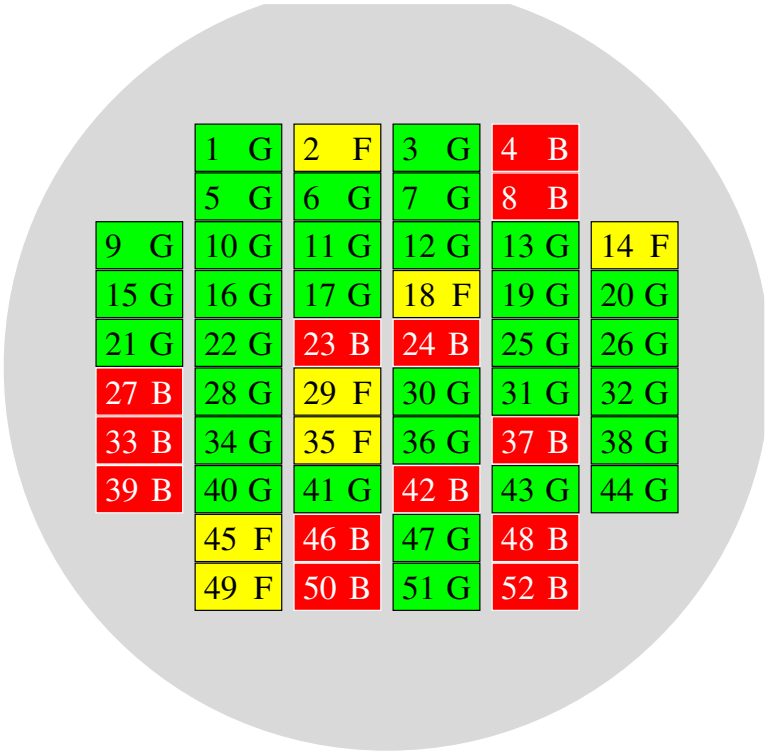
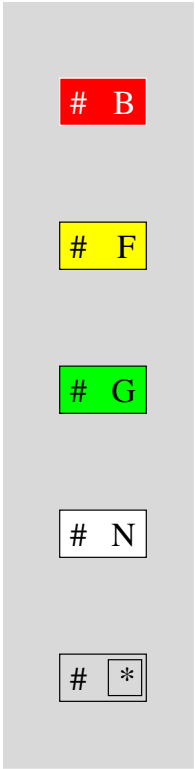
Die quality map for wafer 62 s/n: 21316-07-02

Date: 01/05/99




Bad die

Fair die

Good die

No info

Manually tagged